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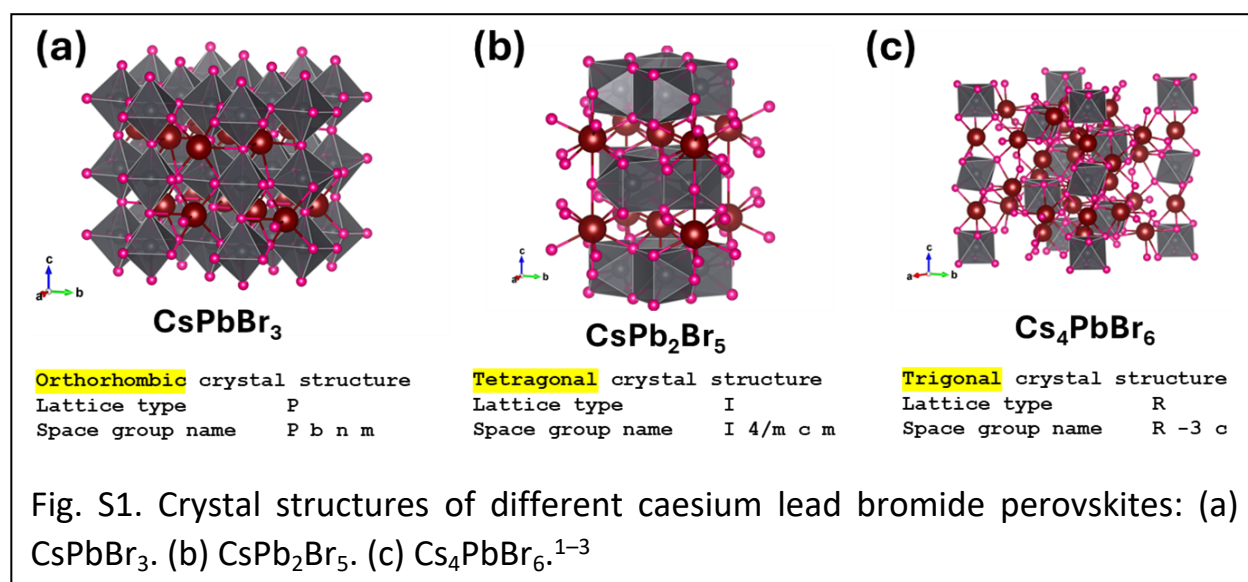
Optimization of CsPbBr₃/PVDF composite for enhanced UV photodetection application

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Supporting Figures



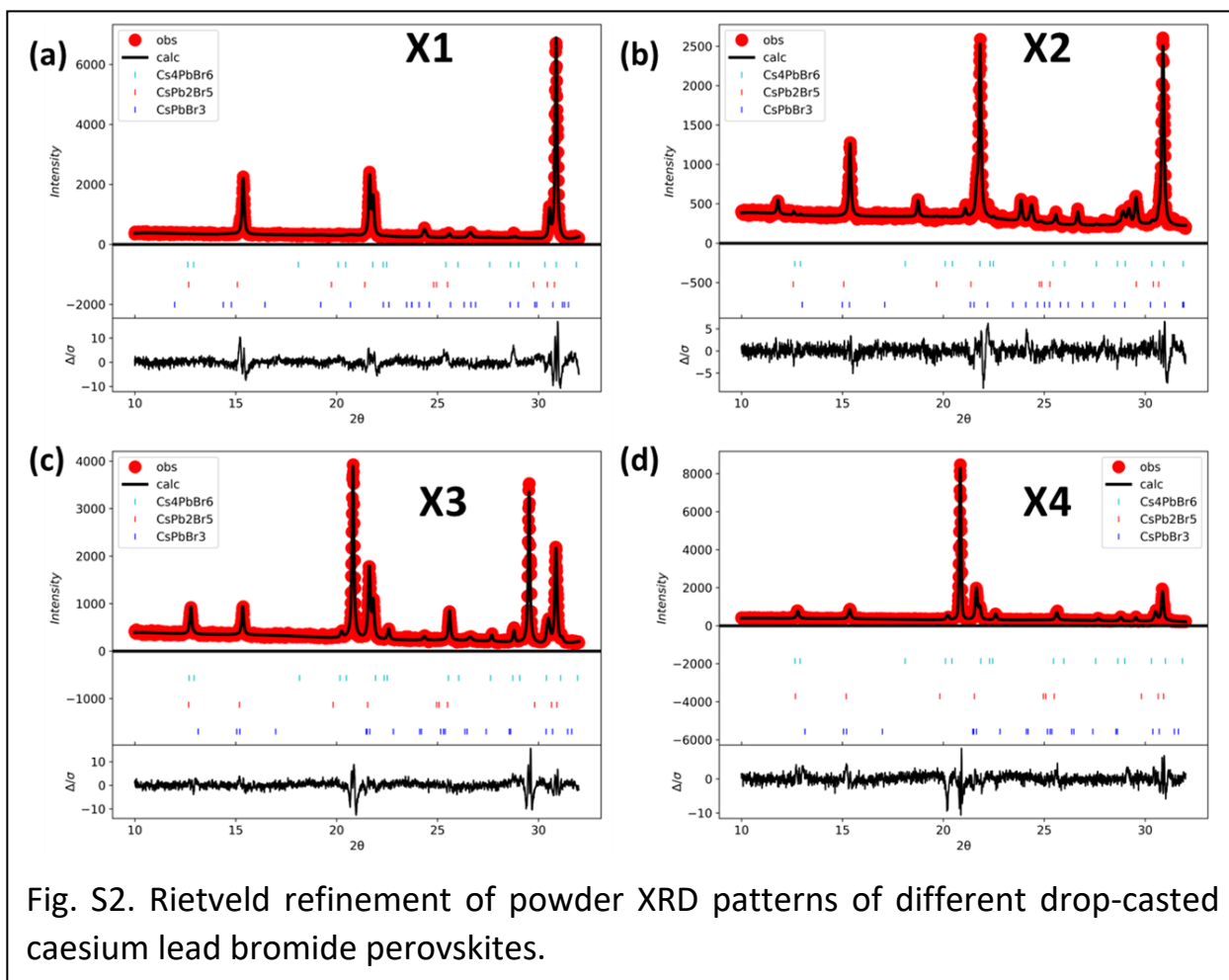
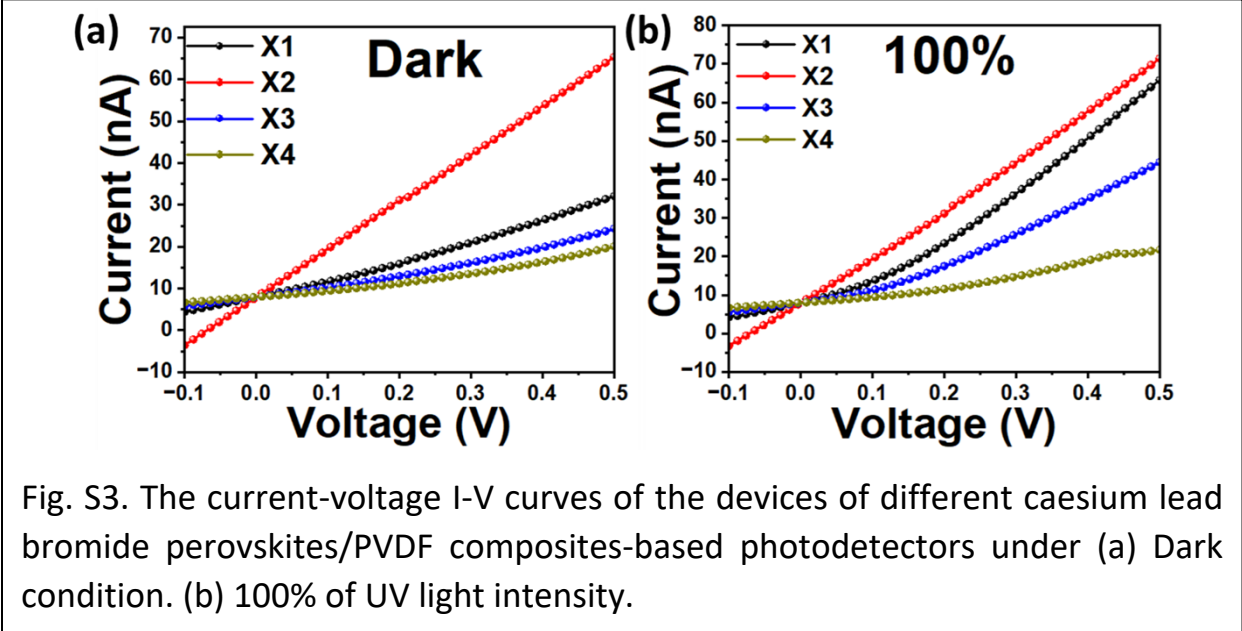


Fig. S2. Rietveld refinement of powder XRD patterns of different drop-casted caesium lead bromide perovskites.



Supporting Notes

Equations used for calculation of Photodetector parameters are shown through the following equations:

$$R_{\lambda} = \frac{\Delta I}{P_{\lambda} \times A} \quad (1)$$

$$\xi = \frac{I_{Photo} - I_{Dark}}{I_{Dark}} \quad (2)$$

$$IQE (\%) = \frac{h \times c \times R_{\lambda}}{e \times \lambda} \times 100\% \quad (3)$$

$$D^* = \frac{R_{\lambda}}{(2 \times e \times J_{Dark})^{\frac{1}{2}}} \quad (4)$$

Where:

R_{λ} : The photoresponsivity of a photodetector which is the photo-current generated through the effective photodetector area per incident light unit power.

ξ : The photosensitivity of a photodetector which is the ratio between the photo-current change under the effect of light illumination and the dark current.

$IQE (\%)$: The internal quantum efficiency of a photodetector to estimate the efficiency of the carrier transport.

D^* : The detectivity of a photodetector which is related to the photodetector quality.

I_{Photo} : The current under light illumination.

I_{Dark} : The current under no illumination.

ΔI : The photo-current change under the effect of light illumination.

P_{λ} : The incident light intensity (W/cm²).

A : The effective area of photodetector (cm²).

h : The plank's constant.

c : The light speed.

e : The electron charge.

λ : The wavelength of the incident light (nm).

References

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